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|-----------------------------------|--|-------------------------------|--|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination GRACIE ET AL. | |
| | | Examiner C. Michelle Colon | Art Unit 3623 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-5,574,828 | 11-1996 | Hayward et al. | 706/45 |
| | B | US-2002/0138408 | 09-2002 | Lawrence, David | 705/38 |
| | C | US-6,912,502 | 06-2005 | Buddle et al. | 705/1 |
| | D | US-6,925,443 | 08-2005 | Baggett et al. | 705/10 |
| | E | US-2002/0099586 | 07-2002 | Bladen et al. | 705/7 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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